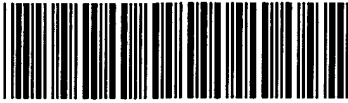


**Search Notes**

Application/Control No.

10/644,262

Examiner

Yalkew Fantu

Applicant(s)/Patent under  
Reexamination

DEHAAN ET AL.

Art Unit

2838

**SEARCHED**

Class	Subclass	Date	Examiner
320	134,122,1 32	3/27/2007	YF

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search history with text	3/27/2007	YF